

HAC RF Test Report

For

Applicant Name: Xwireless LLC

Address: 11565 Old Georgetown Road, Rockville, MD, USA

EUT Name: Mobile Phone

Brand Name: Vortex Model Number: HD60L

Issued By

Company Name: BTF Testing Lab (Shenzhen) Co., Ltd.

F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park,

Address: Tantou Community, Songgang Street, Bao'an District, Shenzhen,

China

Report Number: BTF230810R00401

Test Standards: ANSI C63.19-2011 FCC 47 CFR §20.19 KDB 285076 D01v06

KDB 285076 D02v04 KDB 285076 D03v01r05

FCC ID: 2ADLJ-HD60L

Test Conclusion: Pass

Test Date: 2023-07-07 Date of Issue: 2023-08-11

Prepared By: Monica Zhou

Monica Zhou / Project Engineer

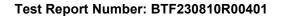
Date: 2023-08-11

Approved By:

Ryan.CJ / EMC Manage

Date: 2023-08-11

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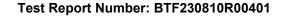


	Revisi	on History			
Version	n Issue Date Revisions Content				
R_V0	2023-08-11	Original			
Note:	Once the revision has	been made, then previous versions reports are invalid.			



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1. Introduction

1.1 Identification of Testing Laboratory

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Phone Number:	+86-0755-23146130
Fax Number:	+86-0755-23146130

1.2 Identification of the Responsible Testing Location

Test Location:	BTF Testing Lab (Shenzhen) Co., Ltd.	
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China	
Description:	All measurement facilities used to collect the measurement data are located at F101,201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China	
FCC Registration Number	518915	
Designation Number	CN1330	

1.3 Laboratory Condition

Ambient Temperature:	21℃ to 25℃
Ambient Relative Humidity:	48% to 59%
Ambient Pressure:	100 kPa to 102 kPa

1.4 Announcement

- (1) The test report reference to the report template version v0.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.
- (5) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- (6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.





2. Product Information

2.1 Application Information

Company Name:	Xwireless LLC
Address:	11565 Old Georgetown Road, Rockville, MD, USA

2.2 Manufacturer Information

Company Name:	Xwireless LLC
Address:	11565 Old Georgetown Road, Rockville, MD, USA

2.3 Factory Information

Company Name:	ZTECH COMMNICATION(SZ) CO LTD
Address:	FL 7 BLOCK D BAO'AN ZHIGU INNOVATION PARK YIN'TIAN ROAD NO.4
Address.	XI'XIANG STR' BAO'AN DISTRICT SZ CHINA

2.4 General Description of Equipment under Test (EUT)

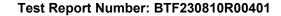
EUT Name	Mobile Phone
Under Test Model Name	HD60L
Sample No.	BTFSN230625E001-2/4

2.5 Equipment under Test Ancillary Equipment

	Rechargeable Battery		
Ancillary Equipment 1	Capacity	2800mAh	
	Rated Voltage	3.8V	

2.6 Technical Information

-		
		2G Network GSM/GPRS 850/1900
		3G Network WCDMA/HSDPA/HSUPA Band 2/4/5
	Network and Wireless	4G Network FDD LTE Band 2/4/5/12/13/25/66/71 TDD LTE Band 41
	connectivity	2.4G WIFI 802.11b, 802.11g, 802.11n(HT20/HT40)
		5G WIFI 802.11a, 802.11n(HT20/HT40), 802.11ac(VHT20/VHT40/VHT80)
		BT (EDR+BLE)





2.7 Air Interfaces / Bands Indicating Operating Modes

Air Interface	Band	Туре	Simultaneous Transmitter	Name of Service
	850	VO	WLAN & BT	CMRS Voice
GSM	1900	VO	WLAN & BT	CMRS Voice
	GPRS/EGPRS	DT	N/A	N/A
	Band II	VO	WLAN & BT	CMRS Voice
WODMA	Band IV	VO	WLAN & BT	CMRS Voice
WCDMA	Band V	VO	WLAN & BT	CMRS Voice
	HSPA	DT	N/A	N/A
	Band 2	VD	WLAN & BT	VoLTE
	Band 4	VD	WLAN & BT	VoLTE
	Band 5	VD	WLAN & BT	VoLTE
	Band 12	VD	WLAN & BT	VoLTE
LTE	Band 13	VD	WLAN & BT	VoLTE
	Band 25	VD	WLAN & BT	VoLTE
	Band 41	VD	WLAN & BT	VoLTE
	Band 66	VD	WLAN & BT	VoLTE
	Band 71	VD	WLAN & BT	VoLTE
WLAN	2.4g & 5g	DT	WWAN	N/A
ВТ	2450	DT	WWAN	N/A

VO: Voice Only
VD: CMRS and IP Voice Service over Digital Transport
DT: Digital Transport Only

* HAC Rating was not based on concurrent voice and data modes; Noncurrent mode was found to represent worst case rating for both M and T rating.

Note1: The air interface is exempted from testing by low power exemption that its average antenna input power plus its MIF is ≤17 dBm, and is rated as M4.

Note2: According to ANS I C63,19 2011-version, for the air interface technology of a device is exempt from testing whose peak antenna input power, averaged over intervals ≤50 μs, is ≤23 dBm. An RF air interface technology that is exempted from testing shall be rated as M4.

3. Summary of Test Results

3.1 Test Standards

No.	Identity	Document Title			
1	ANSI C63.19-2011	American National Standard for Methods of Measurement of Compatibility between Wireless Communication Devices and Hearing Aids			
2	FCC 47 CFR §20.19	Hearing Aid Compatible Mobile Headsets			
3	KDB 285076 D01v06	Equipment Authorization Guidance for Hearing Aid Compatibility			
4	KDB 285076 D02v04	Guidance for performing T-Coil tests for air interfaces supporting voice over IP (e.g., LTE and WiFi) to support CMRS based telephone services			
5	KDB 285076 D03v01r05	Hearing aid compatibility frequently asked questions			





3.2 ANSI C63.19 HAC RF Categories

The ANSI Standard presents performance requirements for acceptable interoperability of hearing with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

WD RF audio Interference level categories in logarithmic units

Emission categories	<960MHz Limits for E-field emissions	>960MHz Limits for E-field emissions
M1	50 to 55 dB (V/m)	40 to 45 dB (V/m)
M2	45 to 50 dB (V/m)	35 to 40 dB (V/m)
M3	40 to 45 dB (V/m)	30 to 35 dB (V/m)
M4	< 40 dB (V/m)	< 30 dB (V/m)

3.3 Summary of HAC M-Rating

Band	Channel	Measuremen	t Result	M-Rating
	Low (128)	E-Field dB (V/m)	31.81	M4
GSM850	Middle(190)	E-Field dB (V/m)	31.52	M4
	High(251)	E-Field dB (V/m)	32.05	M4
	Low (512)	E-Field dB (V/m)	23.35	M4
GSM1900	Middle(661)	E-Field dB (V/m)	24.12	M4
	High(810)	E-Field dB (V/m)	26.02	M4
		HAC Rate Category:		

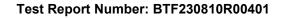




3.4 HAC Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in ANSI C6 3.19: 2011. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level usin g a coverage factor of k=2.

UNCERTAINT	Y EVALUATION FO	OR RF HAC ME	EASUREME	NT	
Uncertainty Component	Tol (±dB)	Prob. Dist.	Div.	Uncertainty (dB)	Uncertainty (%
	Measuremer	nt System			
RF reflections	0.1	R	√3	0.06	
Field probe conv. Factor	0.4	R	√3	0.23	
Field probe anisotropy	0.25	R	√3	0.14	
Positioning accuracy	0.2	R	√3	0.12	
Probe cable placement	0.1	R	√3	0.06	
System repeatability	0.2	R	√3	0.12	
EUT repeatability	0.4	N	1	0.40	
Combined Standard Uncertainty		N	1	0.52	
Expanded Uncertainty (95% CONFIDENCE INTERVAL)		N	K=2	1.03	12.65
REPORTED Expanded uncertainty (confidence level of 95%, k = 2)		N	K=2	1.00	13.00





4. Measurement System

4.1 Definition of Hearing Aid Compatibility (HAC)

The purpose of this standard is to establish categories for hearing aids and for WD (wireless communications devices) that can indicate to health care practitioners and hearing aid users which hearing aids are compatible with which WD, and to provide tests that can be used to assess the electromagnetic characteristics of hearing aids and WD and assign them to these categories. The various parameters required, in order to demonstrate compatibility and accessibility are measured. The design of the standard is such that when a hearing aid and WD achieve one of the categories specified, as measured by the methodology of this standard, the indicated performance is realized.

In order to provide for the usability of a hearing aid with a WD, several factors must be coordinated:

- a) Radio frequency (RF) measurements of the near-field electric and magnetic fields emitted by a WD to categorize these emissions for correlation with the RF immunity of a hearing aid.
- b) Magnetic field measurements of a WD emitted via the audio transducer associated with the T-coil mode of the hearing aid, for assessment of hearing aid performance.
- c) Measurements with the hearing aid and a simulation of the categorized WD T-coil emissions to assess the hearing aid RF immunity in the T-coil mode.

The WD radio frequency (RF) and audio band emissions are measured.

Hence, the following are measurements made for the WD:

- a) RF E-Field emissions
- b) T-coil mode, magnetic signal strength in the audio band
- c) T-coil mode, magnetic signal and noise articulation index
- d) T-coil mode, magnetic signal frequency response through the audio band

Corresponding to the WD measurements, the hearing aid is measured for:

- a) RF immunity in microphone mode
- b) RF immunity in T-coil mode



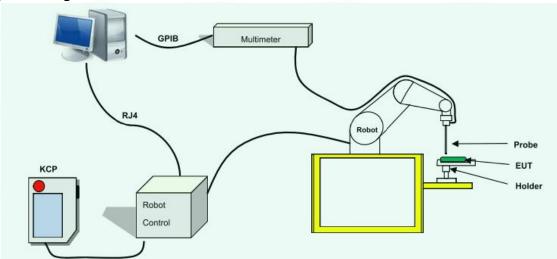


4.2 HAC RF Test Configuration and Setting

For HAC RF emission testing, the EUT was linked and controlled by wireless communication test set. Communication between the EUT and the wireless communication test set was established by air link. The distance between the EUT and the communicating antenna of the test set is larger than 50 cm and the output power radiated from the wireless communication test set antenna is at least 30 dB smaller than the output power of EUT. The EUT was set from the wireless communication test set to radiate maximum output power during HAC testing.

4.3 MVG HAC System

MVG HAC System Diagram







4.3.1 Robot



A standard high precision 6-axis robot (Denso) with t eaches pendant with Scanning System

- · It must be able to scan all the volume of the phanto m to evaluate the tridimensional distribution of SAR.
- \cdot Must be able to set the probe orthogonal of the surface of the phantom ($\pm 30^{\circ}$).
- \cdot Detects stresses on the probe and stop itself if nec essary to keep the integrity of the probe.

4.3.2 E-Field Probe



Figure 1 - MVG COMOHAC E field Probe

Probe Length	330 mm
Length of Individual Dipoles	3.3 mm
Maximum external diameter	8 mm
Probe Tip External Diameter	5 mm
Distance between dipoles / probe extremity	3 mm

Device Type	COMOHAC E FIELD PROBE
Manufacturer	MVG
Model	SCE
Serial Number	SN 07/22 EPH50
Product Condition (new / used)	New
Frequency Range of Probe	0.7GHz-2.5GHz
Resistance of Three Dipoles at Connector	Dipole 1: R1=0.208 MΩ
	Dipole 2: R2=0.220 MΩ
	Dipole 3: R3=0.212 MΩ





4.3.3 Device Holder/DUT positioner





During test, use DUT positioner adjust DUT to check if the Speaker is aligned with the positi oner center.



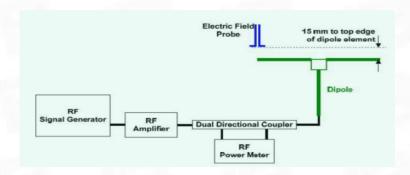


5. System Validation

According to ANSI C63.19, before hearing aid testing commences, the experimental setup shall be validated. Sub clauses 6.3.1through 6.3.5 include a set of pretest procedures designed to validate the experimental setup to ensure the accuracy of the results. To verify that the hearing aid performs per the manufacturer's specifications, 6.3.5 advises that the hearing aid be pretested per ANSI S3.22.

5.1 System Validation Setup

Using this setup configuration, the signal generator was adjusted for the desired output power 20dBm (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole



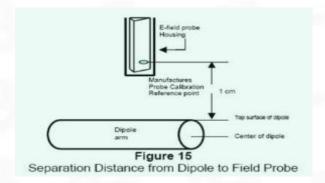
5.2 System Check Procedure

The input signal was an unmodulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power P = 100mW RMS (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 1 cm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:



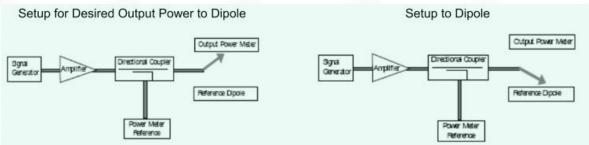




RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system. To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device (e.g. – for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (i.e. - 20dBm) RMS after adjustment for any mismatch.

5.3 System Validation Procedure

A dipole antenna meeting the requirements given in C63.19 was placed in the position normally occupied by the WD. The le ngth of the dipole was scanned with both E-field and H-field probes and the maximum values for each were recorded. Usi ng the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading obs erved. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-paralellity of the setup see manufacturer method on dipole calibration certificates, Field strength mea surements shall be made only when the probe is stationary. RF power was recorded using both an average and a peak pow er reading meter.







6. Modulation Interference Factor (MIF)

The HAC Standard ANSI C63.19-2011 defines a new scaling using the Modulation Interference Factor (MIF). For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be devel oped that relates its interference potential to its steady-state rms signal level or average power level. This factor is a f unction only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strengt h and conducted power measurements. It is important to emphasize that the MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic. Any change in modulation characteristic requires determination and application of a new MIF.

The MIF may be determined using a radiated RF field, a conducted RF signal, or in a preliminary stage, a mathematical analysis of a modeled RF signal:

- a) Verify the slope accuracy and dynamic range capability over the desired operating frequency band of a fast probe or sensor, square-law detector, as specified in D.3, and weighting system as specified in D.4 and D.5. For the probe and instrumentation included in the measurement of MIF, additional calibration and application of calibration factors are not required.
- b) Using RF illumination or conducted coupling, apply the specific modulated signal in question to the measurement system at a level within its confirmed operating dynamic range.
- c) Measure the steady-state rms level at the output of the fast probe or sensor.
- d) Measure the steady-state average level at the weighting output.
- e) Without changing the square-law detector or weighting system, and using RF illumination or conducted coupling, substitute for the specific modulated signal a 1kHz, 80% amplitude-modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the step d) measurement.
- f) Without changing the carrier level from step e), remove the 1 kHz modulation and again measure the steady-state rms level indicated at the output of the fast probe or sensor.
- g) The MIF for the specific modulation characteristic is provided by the ratio of the step f) measurement to the step c) measurement, expressed in dB (20 × log(step f))/step c)).

In practice, step e) and step f) need not be repeated for each MIF determination if the relationship between the two measurements has been preestablished for the measurement system over the operating frequency and dynamic ranges.

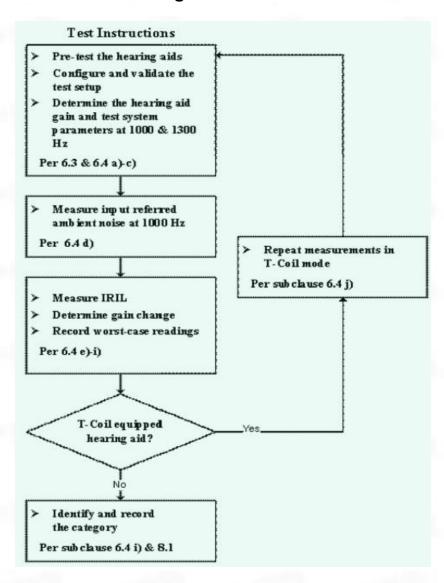
Modulation group	Modulation characteristics	MIF
CW	cw	-99.0
GSM	TDMA	3.3
WCDMA	UMTS-FDD	-27.2
LTE	LTE-FDD / RB=1 / BW=20 MHz / QPSK	-15.6

Test Report Number: BTF230810R00401



7. HAC Immunity Measurement Procedures

7.1 HAC Measurement Process Diagram







7.2 HAC RF Test Setup



WD reference and plane for RF emission measurements

7.3 RF Emission Measurement Procedures

The following illustrate a typical RF emissions test scan over a wireless communications device:

- a. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
- b. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
- c. WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
- d. center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
- e. urface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
- f. measurement system measured the field strength at the reference location





8. Max. Conducted RF Output Power

2G

		Burst Average Power (dBm)			
Mode: GSM850	Maximum Tune- up(dBm)	CH128	CH190	CH251	
	· F(824.2MHz	836.6MHz	848.8MHz	
GSM	32.00	31.71	31.95	31.92	
		Burst Average Power (dBm)			
Mode: GSM1900	Maximum Tune- up(dBm)	CH512	CH661	CH810	
	,	1850.2MHz	1880.0MHz	1909.8MHz	
GSM	26.00	25.57	25.56	25.11	

3G

		WCDMA Band II					
Mode	Maximum Tune-	Conducted Power (dBm)					
Wode	up(dBm)	CH9262	CH9400	CH9538			
		1852.4	1880.0	1907.6			
RMC 12.2K	23.00	22.49	22.48	22.81			
		WCDMA Band IV					
Mode	Maximum Tune- up(dBm)	Conducted Power (dBm)					
Wode		CH1312	CH1413	CH1513			
		1712.4	1732.6	1752.6			
RMC 12.2K	23.50	23.36	23.25	22.92			
		WCDMA Band V					
Mode	Maximum Tune-	Conducted Power (dBm)					
iviode	up(dBm)	CH4132	CH4183	CH4233			
		826.4	836.6	846.6			
RMC 12.2K	26.00	25.48	25.55	25.59			

4G

	LTE-FDD E	Band 2				Conducted Power(dBm)			
S		RB	DD - # 4	Maximum Tune- up(dBm)	18700	18900	19100		
Bandwidth	Modulation	allocation	RB offset	ир(иВііі)	1860.0MHz	1880.0MHz	1900.0MHz		
			0	21.50	21.04	20.89	21.11		
		1	50	22.00	21.48	21.55	21.78		
			99	21.50	20.91	21.06	21.31		
	QPSK	SK 50	0	20.50	20.42	20.32	20.46		
			25	21.00	20.30	20.30	20.53		
			50	21.00	20.32	20.29	20.51		
00141		100	0	21.00	20.40	20.35	20.51		
20MHz	16QAM		0	21.00	20.25	20.06	20.55		
			1	50	21.50	20.58	20.71	21.06	
			99	21.00	19.96	20.30	20.83		
			0	19.50	19.48	19.33	19.45		
		50	25	20.00	19.36	19.35	19.53		
			50	20.00	19.38	19.35	19.55		
		100	0	20.00	19.44	19.41	19.55		





	LTE-FDD Ba	and 4			Conducted Power(dBm)		
Daniel de la constante	NA - dudatia a	RB	RB	Maximum Tune- up(dBm)	20050	20175	20300
Bandwidth	Modulation	allocation	offset	ир(иВт)	1720.0MHz	1732.5MHz	1745.0MHz
			0	22.50	22.07	21.82	21.77
		1	50	22.50	22.39	22.36	22.14
			99	22.00	21.79	21.73	21.53
	QPSK	50	0	21.50	21.31	21.40	21.17
			25	21.50	21.27	21.25	21.08
			50	21.50	21.10	21.18	20.91
001411-		100	0	21.50	21.24	21.29	21.05
20MHz			0	21.50	21.45	21.09	21.17
		1	50	22.00	21.88	21.62	21.44
			99	21.50	21.47	21.01	20.64
	16QAM	16QAM	0	20.50	20.21	20.42	20.13
		50	25	20.50	20.24	20.29	20.04
			50	20.50	20.06	20.19	19.88
		100	0	20.50	20.18	20.29	20.04

	LTE-FDD Bar	nd 5				Conducted Power(dBm)	
Bandwidth		RB	RB	Maximum Tune- up(dBm)	20450	20525	20600
Bandwidth	Modulation	allocation	offset	ир(ивпі)	829.0MHz	836.5MHz	844.0MHz
			0	24.50	24.16	24.05	24.11
		1	25	24.50	24.42	24.32	24.40
			49	24.50	24.05	24.15	24.16
	QPSK		0	23.50	23.17	23.13	23.12
	16QAM	25	13	23.50	23.14	23.11	23.05
			25	23.50	23.08	23.00	23.03
401411-		50	0	23.50	23.10	23.03	23.08
10MHz			0	23.50	23.13	23.46	22.91
		1	25	24.00	23.34	23.71	23.12
			49	23.50	23.20	23.28	22.91
			0	22.50	22.15	22.25	22.15
		25	13	22.50	22.13	22.22	22.10
			25	22.50	22.15	22.09	22.16
		50	0	22.50	22.12	22.16	22.13

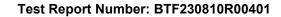
	LTE-FDD Ban	d 12			Conducted Power(dBm)		
Bandwidth	Modulation	RB	RB	Maximum Tune- up(dBm)	23060	23095	23130
Sanuwium	Wodulation	allocation	offset	ωρ(ωΞ)	704.0MHz	707.5MHz	711.0MHz
			0	24.50	23.95	23.97	24.14
		1	25	24.50	24.29	24.36	24.40
			49	24.50	24.14	24.15	24.35
	QPSK		0	23.50	23.32	23.01	22.93
		25	13	23.50	23.18	23.18	23.14
			25	23.50	23.33	23.14	22.92
10MHz		50	0	23.50	23.33	23.13	22.94
TUIVIHZ			0	23.50	22.98	23.43	22.97
		1	25	24.00	23.40	23.65	23.36
			49	24.00	23.16	23.54	23.12
	16QAM		0	22.50	22.28	22.01	21.91
		25	13	22.50	22.11	22.14	22.13
			25	22.50	22.30	22.15	21.94
		50	0	22.50	22.28	22.02	21.90



	LTE-FDD Band 13				Conducted Power(dBm)	
Bandwidth	Modulation	RB	RB		23230	
Banawaan	Modulation	allocation	offset	• • •	782.0MHz	
			0	24.50	24.33	
		1	25	24.50	24.46	
			49	24.50	24.32	
	QPSK	K 25	0	24.00	23.54	
			13	23.50	23.39	
			25	23.50	23.45	
10MHz		50	0	23.50	23.49	
TUIVINZ			0	23.50	23.17	
		1	25	23.50	23.49	
			49	23.50	23.13	
	16QAM		0	23.00	22.59	
		25	13	22.50	22.44	
			25	22.50	22.49	
		50	0	22.50	22.47	

	LTE-FDD Ba	nd 25		Maximum Tune- up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB	RB		26140	26365	26590
Danuwiuin	Wodulation	allocation	offset	up(u=)	1860.0MHz	1882.5MHz	1905.0MHz
			0	20.50	20.29	20.46	20.41
		1	50	21.50	20.65	21.11	20.99
			99	21.00	20.29	20.47	20.97
	QPSK	50	0	20.00	19.64	19.96	19.74
			25	20.00	19.52	19.87	19.87
			50	20.00	19.66	19.78	19.99
000411-		100	0	20.00	19.63	19.91	19.91
20MHz			0	20.00	19.83	19.55	19.47
		1	50	20.50	20.08	20.26	20.27
			99	20.50	19.67	19.57	20.09
	16QAM		0	19.50	18.74	19.06	18.78
		50	25	19.00	18.54	18.97	18.91
			50	19.50	18.66	18.87	19.04
		100	0	19.00	18.72	18.99	18.98

LTE-TDD Band 41					Conducted Power(dBm)			
		RB	RB	Maximum Tune- up(dBm)	39750	40620	41490	
Bandwidth	Modulation	allocation	offset	ир(иып)	2506.0MHz	2593.0MHz	2680.0MHz	
			0	24.50	22.23	23.19	24.23	
		1	50	25.00	22.78	23.93	24.63	
			99	24.50	22.38	23.61	24.03	
	QPSK	50	0	24.00	21.63	22.68	23.57	
			25	23.50	21.49	22.69	23.35	
			50	23.50	21.55	22.70	23.23	
20MHz		100	0	23.50	21.62	22.67	23.37	
ZUIVIHZ			0	23.50	21.28	21.91	23.34	
			1	50	23.50	21.85	22.52	23.39
			99	23.00	21.31	22.59	22.91	
	16QAM	16QAM	0	23.00	20.57	21.61	22.52	
		50	25	22.50	20.41	21.64	22.29	
			50	22.50	20.40	21.65	22.12	
			100	0	22.50	20.48	21.62	22.34





	LTE-FDD Ba	nd 66				Conducted Power(dBm)	
Bandwidth	Modulation	RB	RB	Maximum Tune- up(dBm)	132072	132322	132572
Danuwiuin	Wodulation	allocation	offset	ωρ(ωΞ)	1720.0MHz	1745.0MHz	1770.0MHz
			0	20.50	19.26	19.98	20.44
		1	50	21.00	20.12	20.24	21.00
			99	20.50	20.06	20.12	20.08
	QPSK		0	20.00	18.76	19.25	19.74
		50	25	20.00	19.03	19.22	19.71
			50	20.00	19.15	19.30	19.52
000411-		100	0	20.00	18.96	19.26	19.61
20MHz		1	0	20.00	18.15	18.92	19.56
			50	20.50	19.13	19.11	20.13
			99	20.00	19.23	18.91	19.58
	16QAM		0	19.00	17.66	18.20	18.56
		50	25	19.00	17.98	18.17	18.56
			50	18.50	18.08	18.21	18.44
		100	0	19.00	17.89	18.21	18.51

	LTE-FDD Bar	nd 71			Conducted Power(dBm)		
		.RB	RB	Maximum Tune- up(dBm)	133222	133322	133372
Bandwidth	Modulation	allocatio n	offset	ир(ивііі)	673.0MHz	683.0MHz	688.0MHz
			0	23.50	23.26	23.25	23.20
		1	50	24.00	23.68	23.56	23.61
			99	23.50	23.29	23.33	23.48
	QPSK		0	23.00	22.67	22.32	22.66
		50	25	23.00	22.62	22.47	22.50
			50	23.00	22.81	22.42	22.72
201411-		100	0	23.00	22.70	22.35	22.67
20MHz			0	23.00	22.59	22.23	21.99
		1	50	23.50	23.06	22.59	22.43
			99	23.00	22.65	22.33	22.24
	16QAM		0	22.00	21.64	21.29	21.57
		50	25	22.00	21.55	21.42	21.48
			50	22.00	21.74	21.38	21.70
		100	0	22.00	21.68	21.34	21.66





9. Low-Power Exemption

9.1 Tune-up Power

Mode	Tune-up Power (dBm)
GSM 850	32.00
GSM 1900	26.00
WCDMA II	23.00
WCDMA IV	23.50
WCDMA V	26.00
LTE Band 2	22.00
LTE Band 4	22.50
LTE Band 5	24.50
LTE Band 12	24.50
LTE Band 13	24.50
LTE Band 25	21.50
LTE Band 41	25.00
LTE Band 66	21.00
LTE Band 71	24.00

9.2 RF Emissions Lower Power Exemption

Mode	Tune-up Power (dBm)	MIF	Power + MIF(dB)	C63.19 Test Required?
GSM 850	32.00	3.3	35.3	Yes
GSM 1900	26.00	3.3	29.3	Yes
WCDMA II	23.00	-27.2	-4.2	No
WCDMA IV	23.50	-27.2	-3.7	No
WCDMA V	26.00	-27.2	-1.2	No
LTE Band 2	22.00	-15.6	6.4	No
LTE Band 4	22.50	-15.6	6.9	No
LTE Band 5	24.50	-15.6	8.9	No
LTE Band 12	24.50	-15.6	8.9	No
LTE Band 13	24.50	-15.6	8.9	No
LTE Band 25	21.50	-15.6	5.9	No
LTE Band 41	25.00	-15.6	9.4	No
LTE Band 66	21.00	-15.6	5.4	No
LTE Band 71	24.00	-15.6	8.4	No





10. Test Equipment List

Description	Manufacturer	Model	Serial No./Version	Cal. Date	Cal. Due
PC	Dell	N/A	N/A	N/A	N/A
Test Software	MVG	N/A	OpenHAC V5.1.3	N/A	N/A
COMOHAC E-field Probe	MVG	SCE	07/22 EPH50	2023/02/06	2024/02/05
COMOHAC 800-950MHz reference dipole	MVG	SIDB835	07/22 DHA69	2023/02/06	2024/02/05
COMOHAC 1700-2000MHz reference dipole	MVG	SIDB1900	07/22 DHB70	2023/02/06	2024/02/05
6 1/2 Digital Multimeter	Keithley	DMM6500	4527164	2022/11/24	2023/11/23
MXG Vector Signal Generator	Agilent	N5182A	MY46240163	2022/11/24	2023/11/23
E-Series Avg. Power Sensor	KEYSIGHT	E9300A	MY55050017	2023/03/24	2024/03/23
EPM Series Power Meter	KEYSIGHT	E4418B	MY41293435	2023/03/24	2024/03/23
10DB Attenuator	MIDWEST MICROWAVE	263-10dB	1	2023/03/24	2024/03/23
Coupler	MERRIMAC	CWM-10R-10.8G	LOT-83391	2023/03/24	2024/03/23
Videband Radio Communication Tester	ROHDE & SCHWARZ	CMW500	161997	2022/11/24	2023/11/23





ANNEX A HAC RF System Validation Result

			E-Field Scan			
Mode	Frequency (MHz)	Input Power (mW)	Measured Value (dBV/m)	Target Value (dBV/m)	Deviation (%)	Limit (%)
CW	835	100	215.88	210.0	-2.80	±25
CW	1900	100	146.86	146.1	-0.52	±25

System check at 835.00 MHz

Date of measurement: 7/7/2023

Experimental Conditions

Probe	SN_0722_EPH50
Signal	CW
Band	CW835
Channels	middle
Frequency (MHz)	835.00

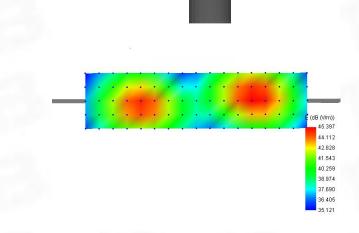
Results

E-field average [dB(V/m)]	215.88
Right E-field maximum [dB(V/m)]	215.56
Left E-field maximum [dB(V/m)]	216.51

Scan parameter

Scan area: length (mm), width (mm)	20.00, 80.00
Measurement point spacing (mm)	5
distance to reference plane (mm)	10.00
X and Y offset with the reference point (mm)	0.00, 0.00
Number of measurement points	85

RF audio interference near field







System check at 1900.00 MHz

Date of measurement: 7/7/2023

Experimental Conditions

Probe	SN_0722_EPH50
Signal	CW
Band	CW1900
Channels	middle
Frequency (MHz)	1900.00

Results

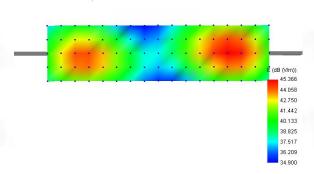
E-field average [dB(V/m)]	146.86
Right E-field maximum [dB(V/m)]	146.32
Left E-field maximum [dB(V/m)]	147.91

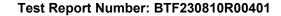
Scan parameter

Scan area: length (mm), width (mm)	20.00, 80.00
Measurement point spacing (mm)	5
distance to reference plane (mm)	10.00
X and Y offset with the reference point (mm)	0.00, 0.00
Number of measurement points	85

RF audio interference near field









ANNEX B HAC RF Measurement Result

Band	Channel	Frequency (MHz)	RF audio interference level [dB(V/m)]	Device compliant	Plot
	Low (128)	824.2MHz	31.81	Yes	1
GSM850	Middle(190)	836.6MHz	31.52	Yes	1
	High(251)	848.8MHz	32.05	Yes	1#
	Low (512)	1850.2MHz	23.35	Yes	1
GSM1900	Middle(661)	1880.0MHz	24.12	Yes	1
	High(810)	1909.8MHz	26.02	Yes	2#

Measurement at GSM850

Date of measurement: 7/7/2023

Experimental Conditions

Experimental conditions		
Probe	SN_0722_EPH50	
Signal	GSM	
Band	GSM850	
Channels	high	
Channels Number	251	
Frequency (MHz)	848.80	
MIF	3.30	

Results

Rocarto	
Maximum value of RF audio interference field [dB(V/m)]	32.05
Category	M4
Measurement status	Complete

Grid visualisation

Legend:

- Blue cells are excluded

- Red cell contains the maximum RF audio interference level

Cell 1:	Cell 2:	Cell 3:
31.91	31.36	30.64
dB(V/m)	dB(V/m)	dB(V/m)
Cell 4:	Cell 5:	Cell 6:
32.28	32.05	31.31
dB(V/m)	dB(V/m)	dB(V/m)
Cell 7:	Cell 8:	Cell 9:
31.19	31.20	30.36
dB(V/m)	dB(V/m)	dB(V/m)

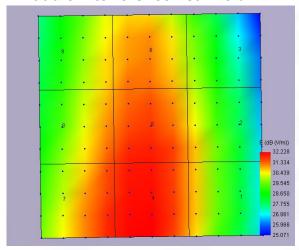




Scan parameter

Scan area: length (mm), width (mm)	50.00, 50.00
Measurement point spacing (mm)	5
distance to reference plane (mm)	15.00
X and Y offset with the reference point (mm)	0.00, 0.00
Number of measurement points	121

RF audio interference near field



Measurement at GSM1900

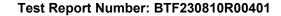
Date of measurement: 7/7/2023

Experimental Conditions

Experimental conditions	
Probe	SN_0722_EPH50
Signal	GSM
Band	GSM1900
Channels	high
Channels Number	810
Frequency (MHz)	1909.80
MIF	3.30

Results

Maximum value of RF audio interference field [dB(V/m)]	26.02
Category	M4
Measurement status	Complete





Grid visualisation

Legend:

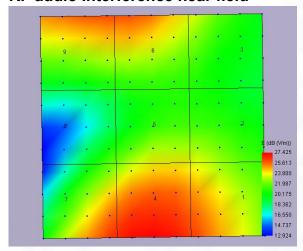
- Blue cells are excluded
- Red cell contains the maximum RF audio interference level

Cell 1:	Cell 2:	Cell 3:
26.45	21.13	26.02
dB(V/m)	dB(V/m)	dB(V/m)
Cell 4:	Cell 5:	Cell 6:
27.43	23.49	26.02
dB(V/m)	dB(V/m)	dB(V/m)
Cell 7:	Cell 8:	Cell 9:
26.45	23.29	23.71
dB(V/m)	dB(V/m)	dB(V/m)

Scan parameter

Scan area: length (mm), width (mm)	50.00, 50.00
Measurement point spacing (mm)	5
distance to reference plane (mm)	15.00
X and Y offset with the reference point (mm)	0.00, 0.00
Number of measurement points	121

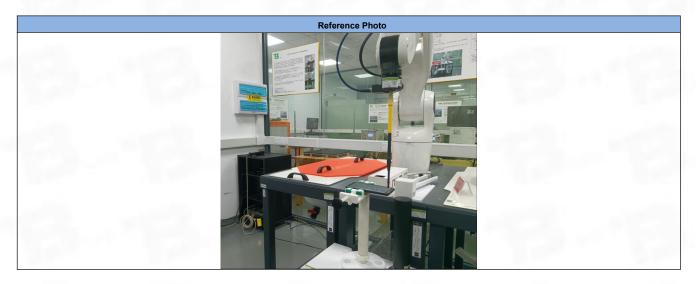
RF audio interference near field



Test Report Number: BTF230810R00401



ANNEX C Test Setup Photos



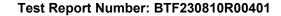
ANNEX D EUT External & Internal Photos

Please refer to RF Report.

ANNEX E Calibration Information

Please refer to the document "Calibration.pdf".







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